

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination	
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Examiner			Art Unit	1792	Page 1 of 1
KEATH T. CHEN					

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*	B	US-2002/0058107	05-2002	Fareed et al.	427/255.39
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**NON-PATENT DOCUMENTS**

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